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L4	4	I2 same (clock near3 (enabl\$4 or provid\$4 or assert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:10
L5	87	I2 and (clock near3 (disabl\$4 or provid\$4 or deassert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:59
L6	9	I2 same (clock near3 (disabl\$4 or provid\$4 or deassert\$4 or select\$5 or adapt\$5))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:13
L7	55	I5 and ((power or energy)near3 (consumption or sav\$4 or reduc\$5 or conserv\$5))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:28
L8	8	((power or energy)near3 (consumption or sav\$4 or reduc\$5 or conserv\$5 or manag\$5))with (ethernet near3 (mac or (media near3 controller)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:56

L9	864	I2 and ((detect\$4 or recogniz\$5 or identif\$4 or determin\$5 or monitor\$4)near3 (operati\$4 or activit\$4 or communicat\$4 or event))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:51
L10	8	I9 and ((clock near3 (enabl\$4 or provid\$4 or assert\$4))with (executi\$4 or operati\$4 or funct\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:37
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L12	0	(csr near2 rmon).clms.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:43
L13	0	(csr ).clms.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:43
L14	27	( rmon).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:43
L15	124	( csr).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:43
L16	27	I14 and I14	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:47

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L18	2	((RMON or(remot\$4 near3 monitor\$4))adj3 counter)same ((csr or (control\$4 near3 status))adj2 register)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:50
L19	28	((RMON or(remot\$4 near3 monitor\$4))adj3 counter)and ((csr or (control\$4 near3 status))adj2 register)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:52
L20	3	l19 and (clock near3 (enabl\$4 or provid\$4 or assert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:43
L21	16	l19 and ((detect\$4 or recogniz\$5 or identif\$4 or determin\$5 or monitor\$4)near3 (operati\$4 or activit\$4 or communicat\$4 or event))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:55
L22	2	l19 and (clock near3 (disabl\$4 or provid\$4 or deassert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:54
L23	3	l21 and (clock near3 (enabl\$4 or provid\$4 or assert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 07:59
L24	3	l21 and (clock near6 (enabl\$4 or provid\$4 or assert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:55

L25	362	saleem.inv.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:43
L26	6	I25 and mohammad	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:43
L27	23592	"713"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:53
L28	1	I27 and (((RMON or(remot\$4 near3 monitor\$4))adj3 counter)and ((csr or (control\$4 near3 status))adj2 register))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 09:10
L29	34299	"709"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 09:09
L30	12	I29 and (((RMON or(remot\$4 near3 monitor\$4))adj3 counter)and ((csr or (control\$4 near3 status))adj2 register))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:56
L31	0	I30 and (clock near3 (disabl\$4 or provid\$4 or deassert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:54
L32	0	I30 and (clock near6 (enabl\$4 or provid\$4 or assert\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:55

L33	9	I30 and ((power or energy)near3 (consumption or sav\$4 or reduc\$5 or conserv\$5 or manag\$5))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 08:57
L34	81788	"370"/\$.ccis.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 09:09
L35	2	I34 and (((RMON or(remot\$4 near3 monitor\$4))adj3 counter)and ((csr or (control\$4 near3 status))adj2 register))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/15 09:10



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**1 Emerging gallium nitride based devices**

*Mohammad, S.N.; Salvador, A.A.; Morkoc, H.;*  
 Proceedings of the IEEE ,Volume: 83 , Issue: 10 , Oct. 1995  
 Pages:1306 - 1355

[\[Abstract\]](#)   [\[PDF Full-Text \(4540KB\)\]](#)   IEEE JNL

**2 Microwave performance of AlGaIn/GaN inverted MODFET's**

*Aktas, O.; Fan, Z.F.; Botchkarev, A.; Mohammad, S.N.; Roth, M.; Jenkins, T.; Kehias, L.; Morkoc, H.;*  
 Electron Device Letters, IEEE ,Volume: 18 , Issue: 6 , June 1997  
 Pages:293 - 295

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**3 The Einstein relation for degenerate semiconductors with nonuniform band structures**

*Mohammad, S.N.; Bemis, A.V.;*  
 Electron Devices, IEEE Transactions on ,Volume: 39 , Issue: 12 , Dec. 1992  
 Pages:2826 - 2828

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**4 Analytical model for I-V characteristics of ion-implanted MESFET's w heavily doped channel**

*Mohammad, S.N.; Patil, M.B.; Chyi, J.I.; Gao, G.B.; Morkoc, H.;*  
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**5 Real-time custom processing and delivery of large ECG data sets**

*Paracha, M.A.; Mohammad, S.N.; Macfarlane, P.W.; Jenkins, J.M.;*  
 Computers in Cardiology, 2003 , 21-24 Sept. 2003  
 Pages:411 - 412



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**6 Implementation of web database for ECG**

*Paracha, M.A.; Mohammad, S.N.; Macfarlane, P.W.; Jenkins, J.M.;*  
Computers in Cardiology, 2003 , 21-24 Sept. 2003  
Pages:271 - 274

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**7 Real-time ECG analysis using a TI TMS320C54/spl times/ digital signal processing chip**

*Mohammad, S.; Lim, Z.; Lin, Y.; Sani, A.; Zanjani, K.; Paracha, M.; Jenkins, J*  
Computers in Cardiology, 2003 , 21-24 Sept. 2003  
Pages:541 - 544

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**8 High current and transconductance AlGaIn/GaN MODFETs at elevated temperatures**

*Aktas, O.; Fan, Z.F.; Lu, C.; Botchkarev, A.; Mohammad, S.; Roth, M.; Morkoc*  
Device Research Conference Digest, 1997. 55th , 23-25 June 1997  
Pages:140 - 141

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**9 A signals and systems and object oriented programming approach to development of ECG analysis software**

*Mohammad, S.N.; Sureka, A.K.; Ely, D.R.; Jenkins, J.M.;*  
Computers in Cardiology, 2002 , 22-25 Sept. 2002  
Pages:153 - 156

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**10 Timed Sequential Changes At The Surface During the Interaction of Blood With Materials**

*Mohammad, S.F.;*  
Biomedical Engineering Conference, 1998. Proceedings of the 17th Southern ,  
Feb. 1998  
Pages:100 - 100

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**11 High-transconductance GaN MODFETs**

*Aktas, O.; Kim, W.; Fan, Z.; Stengel, F.; Botchkarev, A.; Salvador, A.; Sverdlo  
B.; Mohammad, S.N.; Morkoc, H.;*  
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**12 Compound semiconductor devices for communication applications**

*Mohammad, S.N.; Morkoc, H.;*  
Military Communications Conference, 1995. MILCOM '95, Conference Record, I

,Volume: 2 , 5-8 Nov. 1995  
Pages:737 - 742 vol.2

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**13 GaAs metal-insulator-semiconductor structure and field effect transistors grown by ex-situ approach**

*Zhi Chen; Mohammad, S.N.;*

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**14 Near-ideal platinum-GaN Schottky diodes**

*Mohammad, S.N.; Fan, Z.; Botchkarev, A.E.; Kim, W.; Aktas, O.; Salvador, A. Morkoc, H.;*

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**15 High transconductance normally-off GaN MODFETs**

*Ozgur, A.; Kim, W.; Fan, Z.; Botchkarev, A.; Salvador, A.; Mohammad, S.N.; Sverdlov, B.; Morkoc, H.;*

Electronics Letters ,Volume: 31 , Issue: 16 , 3 Aug. 1995

Pages:1389 - 1390

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**16 Characteristics of p-Ge/N-GaAs heterojunctions grown by molecular beam epitaxy**
*Unlu, M.S.; Strite, S.; Won, T.; Adomi, K.; Chen, J.; Mohammad, S.N.; Biswas Morkoc, H.;*

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 Pages:1359 - 1360

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**17 Heavy doping for improved short-channel operation of GaAs MESFE**
*Mohammad, S.; Patil, M.B.; Morkoc, H.;*

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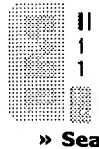
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**1 Effect of electricity pricing (tariffs) variations on consumption and demand of residential dominated system. I. Calculation of power dema for the various sectors**
*Alabbas, A.M.; Saleem, M.H.;*

Electrotechnical Conference, 1996. MELECON '96., 8th Mediterranean ,Volume 2 , 13-16 May 1996

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**2 A simple automatic system for calibration of inductive voltage divide**
*Saxena, A.K.; Saleem, M.;*

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**3 Automatic signature files update in antivirus software using active packets**
*Badhusha, A.; Buhari, S.; Junaidu, S.; Saleem, M.;*

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**4 Automatic bridge for comparison of inductances based on difference voltage measurement**
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**5 Intercomparison of a 10 pF standard capacitor between NPL and PTB**  
*Saxena, A.K.; Saleem, M.; Hanke, R.; Eckardt, H.; Bemme, W.;*  
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**6 Using Secondary Evaporator For A Window Type Air-Conditioner**  
*Said, S.A.; Saleem, M.; Nasir, F.S.; Alnajjar, R.M.;*  
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